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FAX TRANSMITTAL

DATE:

December 26, 2007

TO:

Examiner Thomas H. Stevens, United States Patent and Trademark Office

FAX PHONE

(571) 273-3715

NO:

FROM:

Rodney C. Tullett

RE:

In re Application of: Yuri Granik and Frank M. Schellenberg

Application No.: 09/898,431

Filed: July 2, 2001

For: METHOD OF COMPENSATING FOR ETCH EFFECTS IN

PHOTOLITHOGRAPHIC PROCESSING

OUR FILE:

1011-78093-02

NO. OF PAGES:

2 (including this cover page)

PLEASE ACKNOWLEDGE RECEIPT BY RETURN TELEPHONE CALL? ⊠Yes □No

INFO:

CONTACT

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transmittal, please call us at (206) 264-2960 as soon as possible and ask

for Jessica Elaine Raucci.

MESSAGE:

Dear Examiner Stevens:

Please confirm the attached document is acceptable and confirm the Examiner Interview is scheduled as originally planned.

With best regards,
Jessica E. Raucci
Legal Assistant to Rodney C. Tullett

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PTOL-413A (10-07)
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	Applican	nt Initiated Inte	rview Request	Form		
			licant: Yuri Gran Status of Ap	nik plication:C	HECEIVED ENTRACHAM CENT	
		(2) Frank Schellenberg			DEC 2 6 2007	
Proposed Date of Interview:		Proposed Time:		ime:	(AM/PM)	
Type of Interview 1 (1) [X] Telephonic		nal (3) [] Vi	deo Conference			
Exhibit To Be Show If yes, provide brief	vn or Demonstra f description:	ted: [] YES	[] NO		_	
		Issues To Be I				
Issues (Rej., Obj., etc)	Claims/ Fig. #s	Prior	Discussed	Agreed	Not Agreed	
(1) Rejection	1,5,8,12,2	Art 3 <u>Kim et al. 6,</u> 9	544,6 9 \$	[]	[]	
(2)			[]	[]	[]	
(3)		·	[]	[]	[]	
(4)	eet Attached	***************************************	[]	[]	[].	
Brief Description of Kim et al. does	not teach us	sing results of	<u>an etch simula</u>	tion to pr	oduce a revised	
set or mask/ret	icle data tha	it is used as a	target layer f	or OPC as .	set forth in	
AN OLO TOOP AS	TH CTAIM D.	biases calcula		itial set	of data within	
An interview was co NOTE: This form sho (see MPEP § 713.01). This application will n	ould be completed ot be delayed fron	by applicant and sub	mitted to the examin	hmit e weitten	record of this	
interview. Phyrefore, as soon as possible.	applicant is advise	ed to file a statement o	f the substance of th	is interview (3	7 CFR 1.133(b))	
Applicant/Applicant's Representative Signature Rodney C. Tullert Examiner/SPE Signature						
Typed/Printed Name 34,0	- "	cpresentative				
	Number, if applic	cable	•			

This collection of information is required by 37 CFR 1.133. The information is required to obtain or retain a bonefit by the public which is to the (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.11 and 1.14. This collection is estimated to take 21 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria. VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

PAGE 2/2 * RCVD AT 12/26/2007 2:14:38 PM [Eastern Standard Time] * SVR:USPTO-EFXRF-5/21 * DNIS:2733715 * CSID: * DURATION (mm-ss):00-50